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INTERNATIONAL PRELIMINARY REPORT ON PATENTABILITY

(Chapter II of the Patent Cooperation Treaty)

(PCT Article 36 and Rule 70)

Applicant's or agent's file reference PU030259	FOR FURTHER A	CTION	See Form PCT/IPEA/416
International application No. PCT/US2004/010789	International filing date 07.04.2004	(day/month/year)	Priority date (day/month/year) 29.08.2003
International Patent Classification (IPC) G06T5/10	or national classification and	PC	
Applicant THOMSON LICENSING S.A.et	al		
This report is the international Authority under Article 35 and	preliminary examination re transmitted to the applica	eport, established by that according to Article 3	is International Preliminary Examining 6.
2. This REPORT consists of a to	tal of 5 sheets, including t	his cover sheet.	•
3. This report is also accompanie	ed by ANNEXES, comprisi	ng:	
a. 🛭 sent to the applicant ar	nd to the International Bure	eau) a total of 3 sheets	, as follows:
	ription, claims and/or draw aining rectifications author	ings which have been a	mended and are the basis of this report ee Rule 70.16 and Section 607 of the
Sheets which supe beyond the disclos Supplemental Box.	ure in the international app	hich this Authority cons plication as filed, as indi	iders contain an amendment that goes cated in item 4 of Box No. I and the
sequence listing and/or	al Bureau only) a total of (i tables related thereto, in once Listing (see Section 80	computer readable form	er of electronic carrier(s)) , containing a only, as indicated in the Supplemental Instructions).
4. This report contains indications	s relating to the following i	tems:	
🛭 Box No. I Basis of the	opinion		
☐ Box No. II Priority			
☐ Box No. III Non-establis	hment of opinion with rega	ard to novelty, inventive	step and industrial applicability
☐ Box No. IV Lack of unity	of invention		
applicability;	citations and explanations		r, inventive step or industrial nent
☐ Box No. VI Certain docu	ments cited		
	cts in the international app		. A
☐ Box No. VIII Certain obse	rvations on the internation	al application	
Date of submission of the demand		Date of completion of th	is report
04.03.2005		12.09.2005	
Name and mailing address of the international		Authorized Officer	nat Pilon.
preliminary examining authority: European Patent Office D-80298 Munich Tel. +49 89 2399 - 0 Tx: 523656 epmu d		Eckert, L	The state of the s
Fax: +49 89 2399 - 4465		Telephone No. +49 89 2	399-7631

INTERNATIONAL PRELIMINARY REPORT ON PATENTABILITY

International application No. PCT/US2004/010789

		AP20 Rec'd PCT/DTO 22 FEB 2006
	Box No. I Basis of the report	
1.	With regard to the language, thi filed, unless otherwise indicated	s report is based on the international application in the language in which it was under this item.
	which is the language of a to international search (und publication of the interna	slations from the original language into the following language, ranslation furnished for the purposes of: ler Rules 12.3 and 23.1(b)) tional application (under Rule 12.4) examination (under Rules 55.2 and/or 55.3)
2.	With regard to the elements* of have been furnished to the receive report as "originally filed" and are	the international application, this report is based on <i>(replacement sheets which iving Office in response to an invitation under Article 14 are referred to in this e not annexed to this report)</i> :
	Description, Pages	
	1-7	as originally filed
	Claims, Numbers	
	1-12	received on 07.03.2005 with letter of 04.03.2005
	Drawings, Sheets	
	1/2, 2/2	as originally filed
	☐ a sequence listing and/or an	y related table(s) - see Supplemental Box Relating to Sequence Listing
3.	☐ The amendments have resu ☐ the description, pages ☐ the claims, Nos. ☐ the drawings, sheets/figs ☐ the sequence listing (spe ☐ any table(s) related to se	pcify):
4.	☐ This report has been establishad not been made, since they he Supplemental Box (Rule 70.2(c))☐ the description, pages☐ the claims, Nos.☐ the drawings, sheetsfigs☐ the sequence listing (spe☐ any table(s) related to se	cify):
		mo or all of there should make a market make the market make t

INTERNATIONAL PRELIMINARY REPORT **ON PATENTABILITY**

International application No. PCT/US2004/010789

Box No. V Reasoned statement under Article 35(2) with regard to novelty, inventive step or industrial applicability; citations and explanations supporting such statement

1. Statement

Novelty (N)

Yes: Claims

1-12

1-12

1-12

Industrial applicability (IA)

No: Claims

Inventive step (IS)

Yes: Claims Claims

No:

Yes: Claims

Claims No:

2. Citations and explanations (Rule 70.7):

see separate sheet

Re. item V:

- Reference is made to the following document:
 D1: US-A-5 641 596 (COK DAVID R ET AL) 24 June 1997 (1997-06-24)
- 2. Since none of the documents cited in the International Search Report contains an indication to derive cut frequencies of 2D band-pass filters which approximate grain patterns when operated on random noise, the application seems to contain subject matter which is both novel and inventive and hence fulfills the requirements of Article 33 PCT. However, the objections listed below apply; for the assessment of novelty and inventive step, the unclear parts have been construed as stated in the following objections.

Clarity:

- 3. The application does not meet the requirements of Article 6 PCT, because claims 1, 6 8 and 10 12 are not clear.
- 3.1. Re. independent claims 1 and 12: It is not clear how film grain samples can be transformed, since these could also exist as chemical structures. According to the description, p. 1, l. 17 28, the claims should have been directed to a method for modeling film grain patterns in a digital image.
- 3.2. Re. dependent claims 6, 7, 10 and 11: It is obscure what the intersection point(s) should be, because it is unclear what exactly intersects the curves. The clear teaching of the description, p. 6, l. 26 p. 7, l. 26, should have been incorporated into the claims.
- 3.3. Re. dependent claim 8: In lines 8 10 of claim 8, reference is made to "a curve" and "the curve", i.e. to a *single* curve. Since according to the description, p. 6, l. 26 p. 7, l. 26, each of the horizontal and vertical mean vectors is represented as a curve and cut frequencies are established from said associated curves, claim 8 should have been formulated accordingly.

Further remarks:

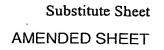
- 4. Contrary to the provisions of R. 6.4(a) PCT and the Guidelines, 5.12 and 5.13, claims 1 and 12 are drafted as separate independent method claims. Since claim 12 furthermore contains all the features of independent claim 1, claim 12 should have been drafted as a claim dependent on claim 1, cf. R. 6.4(a) PCT and the Guidelines, 5.15.
- 5. Contrary to the provisions of Rule 6.2(b) PCT, the features of the claims are not provided with reference signs placed in parentheses.
- 6. The description, p. 7, l. 21f. states that like numerals were used in fig.s 1 and 2, but actually, both figures do not have any numerals in common. As a consequence, the reference to "steps 107 and 108" (cf. p. 7, l. 24) is incorrect.
- 7. Contrary to the requirements of Rule 5.1(a)(ii) PCT, the documents **D1** is neither identified in the description, nor is the relevant background art disclosed therein briefly discussed.

10/569318 WP20 Rec'd PCT/PTO 22 FEB 2006

- 8 -

CLAIMS

1.	1. A method for automatically modeling film grain patterns, comprising the steps of:			
2	transforming a set of film grain samples, comprised of at least one group of neighboring			
3	pixels that retains information about film grain shape and size, to the frequency domain;			
4	storing each set of coefficients resulting from such transform, the coefficients forming a			
.5	pattern;			
6	analyzing the pattern created by the transform coefficients; and			
7	estimating the cut frequencies of a 2D band-pass filter that can simulate the pattern of			
8	transform coefficients by filtering random noise in a frequency domain.			
·i	2. The method according to claim 1 further comprising the step of transmitting at			
2				
1,	3. The method according to claim 1 wherein the film grain samples are processed in			
2	blocks of N x N pixels.			
. 1	4. The method according to claim 3 wherein the step of analyzing the pattern created			
.2	by the transform coefficients further comprises the steps of:			
3	computing a mean block of N x N transform coefficients by averaging the transform			
4	coefficients from all the stored blocks following a transformation of each N x N pixel block;			
5	defining horizontal and vertical mean vectors of N components each by averaging the			
6	mean block of N x N coefficients along rows and columns, respectively;			
7	representing the horizontal and vertical mean vectors as separate curves; and			
. 8	establishing horizontal and vertical cut frequencies from the curves represented by the			
9	horizontal and vertical mean vectors, respectively.			
1	5. The method according to claim 4 further comprising the step of low pass filtering			
2	at least one mean vector.			
1	6. The method according to claim 4 wherein one of the horizontal and vertical cut			
2	frequencies is established from an intersection point in the curve representing a corresponding			
3	one of the mean horizontal and vertical vectors, respectively.			





1	7. The method according to claim 4 wherein each of a low and a high horizontal and		
2	vertical cut frequencies is established from a first and second intersection points in the curve		
3	representing the mean horizontal and vertical vectors, respectively.		
1	8. The method according to claim 3 wherein the step of analyzing the pattern created		
2	by the transform coefficients further comprises the steps of:		
3	computing a mean block of N x N transform coefficients by averaging the transform		
4	coefficients from all the stored blocks following a transformation of each pixel block;		
5	defining horizontal and vertical mean vectors of N components each by averaging the		
6	mean block of N x N transform coefficients along rows and columns, respectively;		
7	averaging the horizontal and vertical mean vectors into a single mean vector;		
8 ·	representing the mean vectors as a curve; and		
9	establishing horizontal and vertical cut frequencies from the curve represented by the		
10	mean vector.		
1	9. The method according to claim 8 further comprising the step of low pass filtering		
2	the mean vector.		
	And the control of th		
1 ·	10. The method according to claim 8 wherein one of a horizontal and vertical cut		
2	frequencies is established from an intersection point in the curve representing a corresponding		
3	one of the mean horizontal and vertical vectors, respectively.		
1	11. The method according to claim 8 wherein each of a low and a high horizontal and		
2	vertical cut frequencies is established from a first and second intersection points in the curve		
3	representing the mean horizontal and vertical vectors, respectively.		

1	12. A method for automatically modeling film grain patterns, comprising the steps of:			
2	receiving a set of film grain samples			
3	performing a transform on the set of film grain samples, comprised of at least one group			
4	of neighboring pixels that retains information about film grain shape and size, to the frequency			
5	domain			
6	storing each set of coefficients resulting from such transform, the coefficients forming a			
7	pattern;			
8	analyzing the pattern created by the transform coefficients; and			
9	estimating the cut frequencies of a 2D band-pass filter that can simulate the pattern of			
С	transform coefficients by filtering random noise in a frequency domain.			
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